PRODUCT SPECIFICATION

1. SCOPE

1.1. Content

This specification covers the performance, tests and quality requirements for the AMP* Crimp Snap Twin Leaf Connector assemblies, used to provide a connection method between discrete wiring and printed circuit boards. Contacts are crimp type, wrap in design. These multi-contact connectors have .100, .125 and .156 inch centerline spacing between adjacent contacts.

1.2. Qualification

When tests are performed on the subject product line, the procedures specified in AMP 109 series specifications shall be used. All inspections shall be performed using the applicable inspection plan and product drawing.

2. APPLICABLE DOCUMENTS

The following documents form a part of this specification to the extent specified herein. In the event of conflict between the requirements of this specification and the product drawing, the product drawing shall take precedence. In the event of conflict between the requirements of this specification and the referenced documents, this specification shall take precedence.

2.1. AMP Specifications

A. 109-1: General Requirements for Test Specifications
B. 109 Series: Test Specifications as indicated in Figure 1. (Comply with MIL-STD-202, MIL-STD-1344 and EIA RS-364)
C. Corporate Bulletin 76: Cross-reference between AMP Test Specifications and Military or Commercial Documents
D. 114- :
E. 501- : Test Report

3. REQUIREMENTS

3.1. Design and Construction

Connectors shall be of the design, construction and physical dimensions specified on the applicable product drawing.

3.2. Ratings

A. Current: 5 amperes maximum per contact
B. Operating Temperature: -55° to 105°C

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DIST 14
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TITLE CONNECTOR, CRIMP SNAP TWIN LEAF

3.4. Performance and Test Description

Connectors shall be designed to meet the electrical, mechanical and environmental performance requirements specified in Figure 1.

3.5. Test Requirements and Procedures Summary

Test Description	Requirement	Procedure
Examination of Product	Meets requirements of product drawing.	Visual, dimensional and functional per applicable inspection plan.
ELECTRICAL		
Termination Resistance, Specified Current	10 milliohms maximum initial	Measure potential drop of mated contacts at 1 ampere test current assembled in housing, see Figure 5; AMP Spec 109-25, calculate resistance.
Termination Resistance, Dry Circuit	10 milliohms maximum initial.	Subject mated contacts assembled in housing to 50 mv open circuit at 100 ma maximum, see Figure 5; AMP Spec 109-6-1.
Dielectric Withstanding Voltage	See Figure 3.	Test between adjacent contacts of unmated connector assemblies; and contacts to mounting hardware; AMP Spec 109-29-1.
Insulation Resistance	5000 megohms minimum initial.	Test between adjacent contacts of unmated connector assembly; AMP Spec 109-28-4, 500 vdc.
Current Cycling	Crimp resistance not to exceed final value.	Subject mated contacts to 50 cycles at 125 % rated current for 30 minutes "ON" - 15 minutes "OFF"; AMP Spec 109-51, cond B, test method 3.

Figure 1 (cont)

Test Description	Requirement	Procedure
Crimp Resistance	AWG / Test Current / Milliohms Init / Milliohms Final 28 / 1.0 / 3.0 / 5.0 26 / 1.0 / 2.5 / 4.0 24 / 3.0 / 2.0 / 3.3 22 / 5.0 / 1.2 / 2.0 20 / 7.5 / 0.7 / 1.2 18 / 10.0 / 0.5 / 0.8 16 / 12.5 / 0.4 / 0.7	Measure potential drop across crimped contacts between wire as it enters the wire barrel and the end of the wire barrel nearest the the contact transition; see Figure 6; AMP Spec 109-25.
MECHANICAL		
Vibration	No discontinuities greater than 1 microsecond. No physical damage.	Subject mated connectors to 10-55-10 Hz traversed in 1 minute at .06 inches total excursion; 2 hours in each of 3 mutually perpendicular planes; AMP Spec 109-21-1.
Physical Shock	No discontinuities greater than 1 microsecond.No physical damage.	Subject mated connector to 100 G's sawtooth in 6 milliseconds; 3 shocks in each direction applied along the 3 mutually perpendicular planes total 18 shocks; AMP Spec 109-26-9.
Mating Force	12 ounces maximum per contact pair.	Measure force necessary to mate connector assembly from point of initial contact, incorporating free floating fixtures at a rate of 0.5 inch/minute; AMP Spec 109-42, cond A, calculate force per contact pair.
Contact Retention (Crimped Contacts)	Contacts shall not dislodge from normal locking position.	Apply axial load of 8 pounds to contact lead; AMP Spec 109-30.
Contact Engaging Force	10 ounces maximum per contact.	Measure force to engage using gage 1, see Figure 7; AMP Spec 109-35.

Figure 1 (cont)

Test Description	Requirement	Procedure
Contact Separating Force	.7 ounces minimum.	Size 3 times using gage 1, see Figure 7, insert gage 2 and measure force to separate; AMP Spec 109-35.
Crimp Tensile	Wire Size, AWG / Crimp Tensile pounds minimum 28 / 3.0 26 / 5.0 24 / 8.0 22 / 12.0 20 / 20.0 18 / 30.0 16 / 42.0	Determine crimp tensile at a rate of linch/ minute; AMP Spec 109-16.
Durability	No physical damage.	Mate and unmate connector assemblies with 30 microinches gold for 250 cycles with gage 1. see Figure 7; AMP Spec 109-27.
ENVIRONMENTAL		
Thermal Shock	No physical damage.	Subject mated connectors to 5 cycles between -55° and 105°C; AMP Spec 109-22.
Humidity, Steady State	1000 megohms final, insulation resistance.	Subject unmated connectors to steady state humidity at 40°C and 90-95% RH; AMP Spec 109-23, method II, cond A.

(a) Shall show no evidence of damage, cracking or chipping.

Figure 1 (end)

3.6. Connector Qualification and Requalification Tests and Sequences

Test or Examination	Test Group (a)		
	1	2	3
	Test Sequence (b)		
Examination of Product	1	1	1
Termination Resistance, Current			
Termination Resistance, Dry Circuit	3,14	3,16	
Dielectric Withstanding Voltage	5,13	5,15	
Insulation Resistance	4,12	4,14	
Crimp Resistance			2,4
Current Cycling			3
Vibration	9	11	
Physical Shock	10	12	
Connector Mating Force	2	2	
Contact Retention	15	17	
Contact Engaging Force		6	
Contact Separating Force	8	7,10	
Crimp Tensile			5
Durability	7	9	
Thermal Shock	6	8	
Humidity, Steady State	11	13	

(a) See Para 4.1.A.
(b) Numbers indicate sequence in which tests are performed.

Figure 2

4. QUALITY ASSURANCE PROVISIONS

4.1. Qualification Testing

A. Sample Selection

Connector housings and contacts shall be prepared in accordance with applicable Instruction Sheets. They shall be selected at random from current production. Test samples shall consist of six connectors of the greatest number of positions of each connector type offered, three each test group 1 and test group 2. Two additional specimens shall be selected from the least number of positions offered and tested to group 2. When connectors are mated, use PC boards as illustrated in Figure 4. Thirty contacts of each style and desired wire size shall be tested to test group 3.

B. Test Sequence

Qualification inspection shall be verified by testing samples as specified in Figure 2.

C. Acceptance

(1) Test results from development on pre-qualification samples will be used to determine upper and lower one-sided statistical tolerance limits for 99% reliability at 95% confidence, as follows. Let Xbar and s denote the sample average and standard deviation, respectively, of the test data. Let k denote the normal distribution one-sided tolerance factor for 95% confidence and 99% reliability. The value of k varies with sample size. Values of k are given in various tables, for example, NBS Handbook 91, Factors for One-Sided Tolerance Limits for Normal Distribution. Suitability of the normal distribution for representing the data shall be verified with normal probability plots, goodness of fit tests, etc.

Then the upper one-sided tolerance limit for 99% reliability at 95% confidence is given by Xbar + ks. The interpretation of this tolerance limit is as follows: based on the test data, and assuming a normal distribution for the test data, we can be 95% confident that 99% of the population of values represented by the sample data will not exceed Xbar + ks. For any test parameter for which there is specified an upper requirement which is not to be exceeded, satisfactory performance of the product is achieved when the value of Xbar + ks does not exceed the requirement value.

The lower one-sided tolerance limit for 95% confidence and 99% reliability is given by Xbar - ks. This has a similar interpretation and corresponding application to lower requirement values.

(2) Failures attributed to equipment, test setup, or operator deficiencies shall not disqualify the product. When product failure occurs, corrective action shall be taken and samples resubmitted for qualification.

4.2. Requalification Testing

Requalification shall be established by the cognizant divisional engineering function and may consist of all or any part of the overall qualification program provided that it is conducted within the required time period.

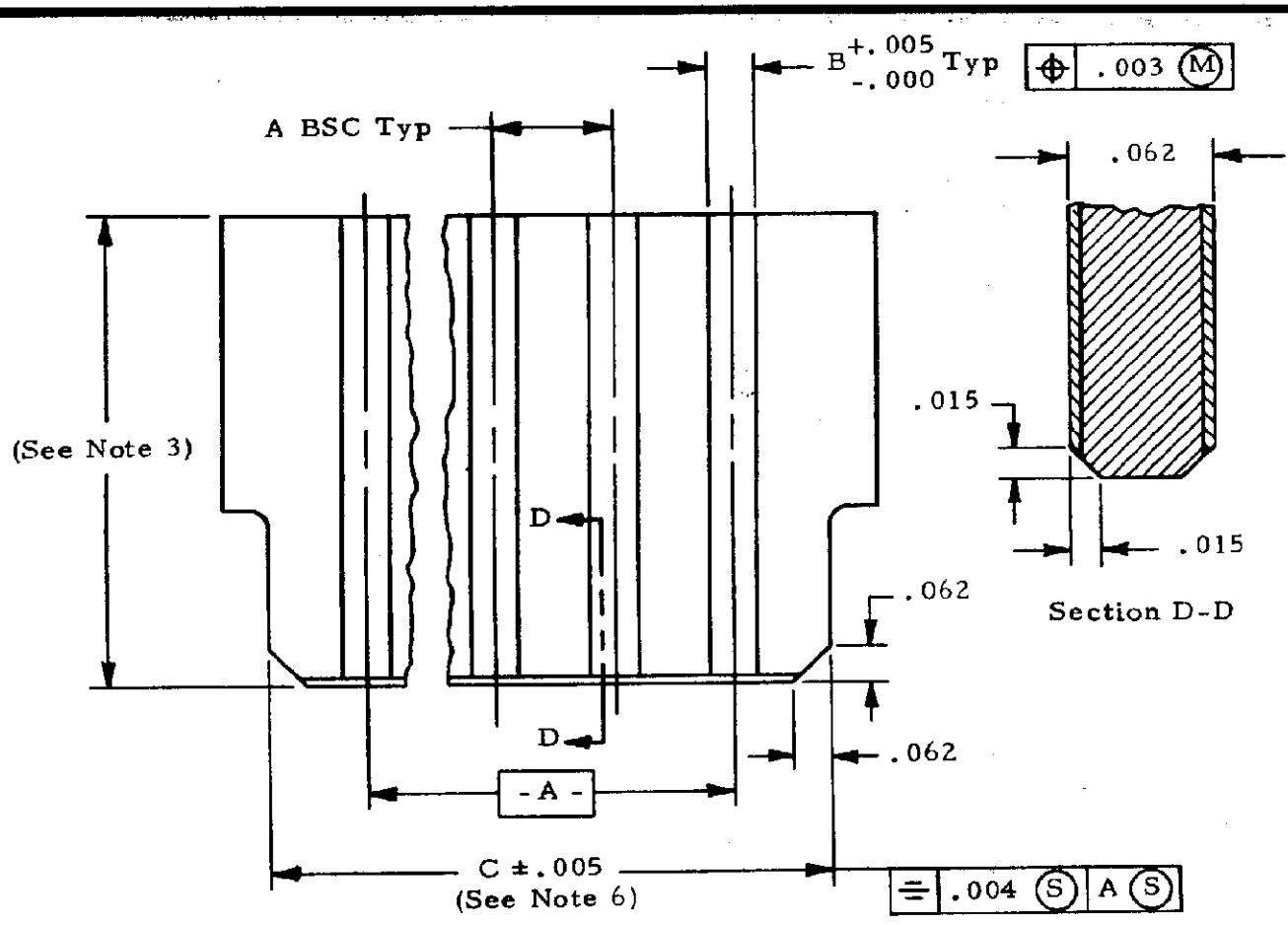
4.3. Quality Conformance Inspection

The applicable AMP inspection plan will specify the sampling acceptable quality level to be used. Dimensional and functional requirements shall be in accordance with the applicable product drawing and this specification.

Altitude feet	Test Voltage, rms		
	.100cl	.125cl	.156cl
Sea Level	1000	1500	1800
50,000	400	525	675
70,000	280	375	450

5 ma maximum leakage
No breakdown or flashover

Figure 3



Connector Contact Spacing	A BSC	B
.100	.100	.052
.125	.125	.078
.156	.156	.094

NOTES:

1. Dimensions are in inches.
2. Unless otherwise specified, tolerance is +/-.005.
3. The test card shall extend 4.00 +/-.02 from the receptacle after insertion.
4. Number of contacts shall be the same as on the corresponding printed wiring board.
5. Printed circuit test board shall be 2 ounces copper and gold over nickel plated per MIL-STD-275.
6. This dimension shall be the minimum connector card slot length minus .008.
7. Conductor configuration optional beyond card slot depth.
8. Printed wiring shall be identical on both sides.

Figure 4
Connector Description

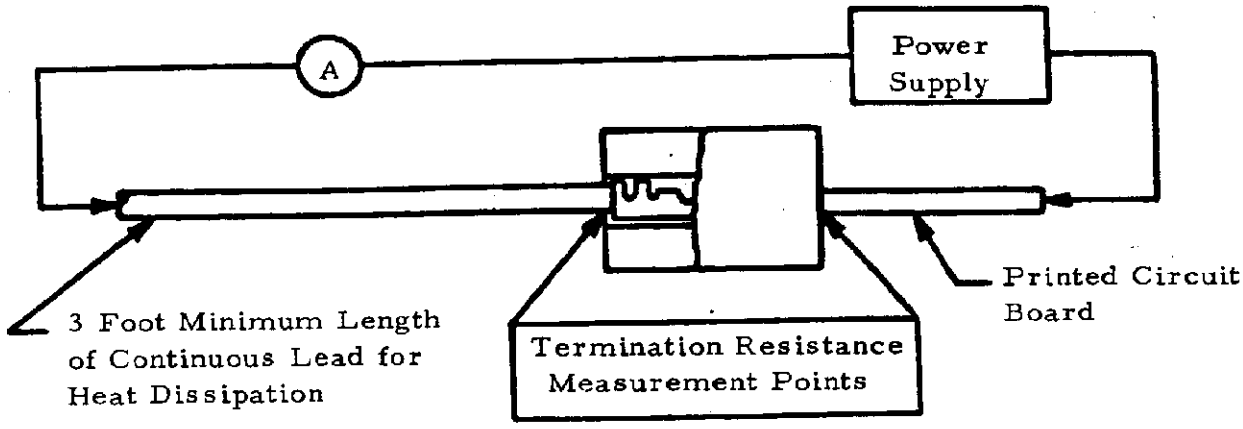


Figure 5
Termination Resistance Test Circuit

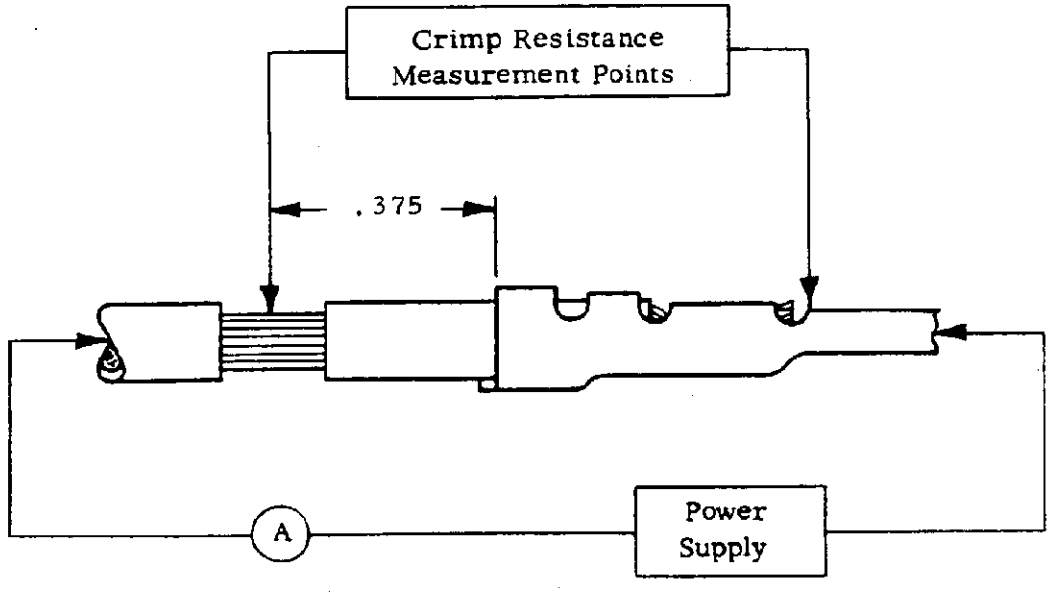
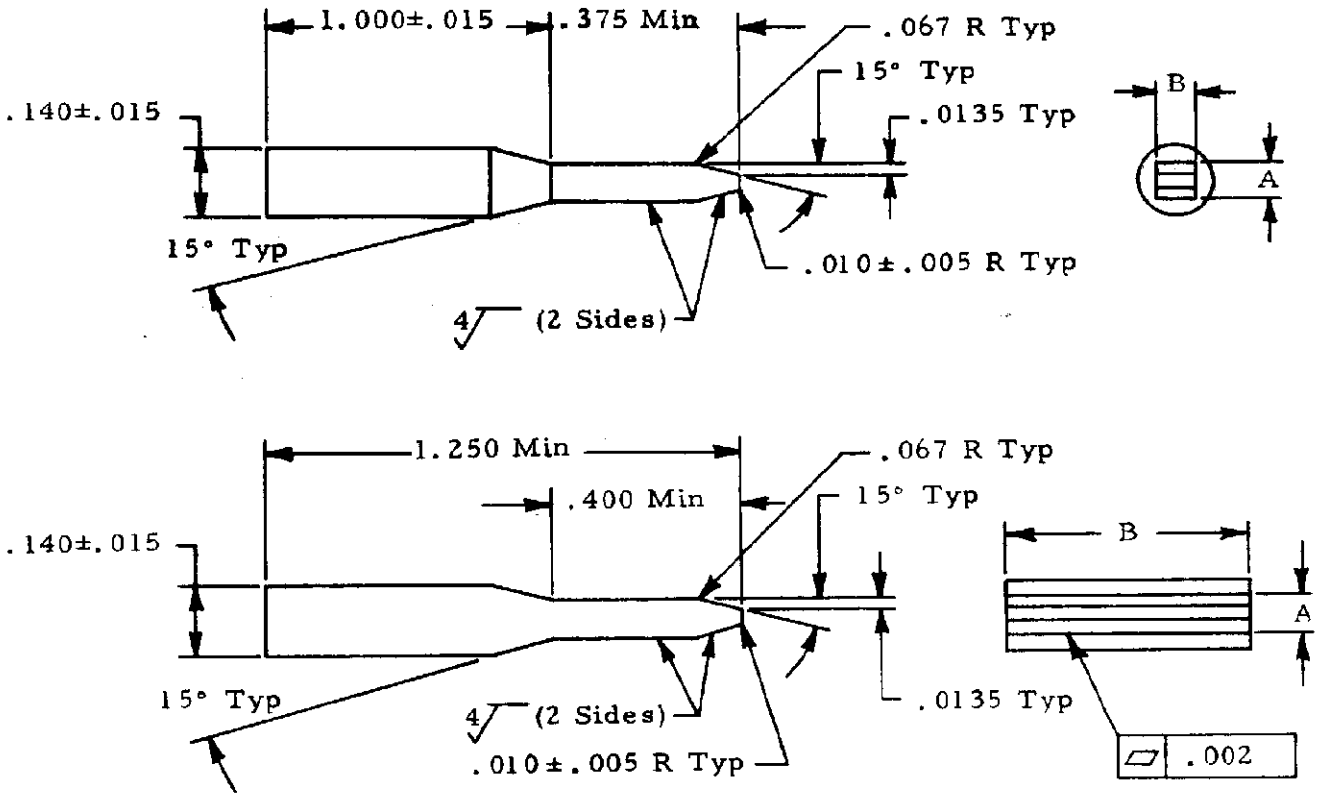


Figure 6
Crimp Resistance



Gage Number	A	B
1	.0700	(a)
2	.0540	(a)

(a) Dimension equals card slot length of connector minus .008.

NOTES:

1. Tolerances: +/-.005 unless otherwise indicated.
2. Material: Tool steel, hardened to Rockwell C50-55.
3. Gage surface shall be clean of contaminants or lubricants.

Figure 7
Printed Board Simulator